

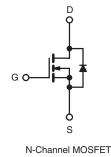
## **IRFI510GPBF-VB Datasheet** N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	100			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.086		
Q <sub>g</sub> (Max.) (nC)	72			
Q <sub>gs</sub> (nC)	11			
Q <sub>gd</sub> (nC)	32			
Configuration	Single			

### **FEATURES**

- Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





<b>ABSOLUTE MAXIMUM RATINGS</b> T	<sub>C</sub> = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	100	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{C} = 25 °C$ $T_{C} = 100 °C$	I <sub>D</sub>	18		
		T <sub>C</sub> = 100 °C		12	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	68		
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	720	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	17	A	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.8	mJ	
aximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	48	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N ⋅ m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 3.7 mH,  $R_G = 25 \Omega$ ,  $I_{AS} = 17 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 17 \text{ A}$ , dl/dt  $\le 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

d. 1.6 mm from case.



#### RoHS COMPLIANT

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PARAMETER	SYMBOL	TYP		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 65						
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 3.1				°C/W		
<b>SPECIFICATIONS</b> $T_J = 25 \degree C$ ,	unless otherv	vise noted						
PARAMETER	SYMBOL		T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								1
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 2	50 μA	100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 2	250 μΑ	1.0	-	3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA
-		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			-	-	25	<u> </u>
Zero Gate Voltage Drain Current	Voltage Drain Current $I_{DSS}$ $V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$		T <sub>J</sub> = 150 °C	-	-	250	μA	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 10 A <sup>b</sup>		-	0.086	-	Ω	
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub> :	= 50 V, I <sub>D</sub> =	10 A <sup>b</sup>	9.1	-	-	S
Dynamic								
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	1700	-	pF	
Output Capacitance	Coss			-	560	-		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	120	-		
Drain to Sink Capacitance	С		f = 1.0 MHz		-	12	-	
Total Gate Charge	Qg				-	-	72	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V} \qquad I_D = 17 \text{ A}, \text{ V}_{DS} = 80 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b}}$		-	-	11	nC
Gate-Drain Charge	Q <sub>gd</sub>				-	-	32	
Turn-On Delay Time	t <sub>d(on)</sub>				-	11	-	
Rise Time	tr	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{DD} = 50 \; {\sf V}, \; {\sf I}_D = 17 \; {\sf A}, \\ {\sf R}_G = 9.1 \; \Omega, \; {\sf R}_D \!$		-	44	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	53	-		
Fall Time	t <sub>f</sub>			-	43	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s	•						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	17	- A	
Pulsed Diode Forward Currenta	I <sub>SM</sub>	integral reverse p - n junction diode			-	-		68
Body Diode Voltage	$V_{SD}$	$T_{J} = 25 \ ^{\circ}C, \ I_{S} = 17 \ A, \ V_{GS} = 0 \ V^{b}$		-	-	2.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			-	180	360	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 17 A, dl/dt = 100 A/µs <sup>b</sup>			-	1.3	2.6	μΟ
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time i	s negligible (turn	-on is dor	ninated by	L <sub>S</sub> and I	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.





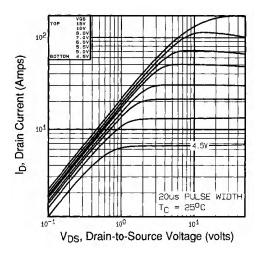


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

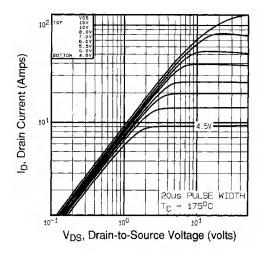


Fig. 2 - Typical Output Characteristics,  $T_C = 175$  °C

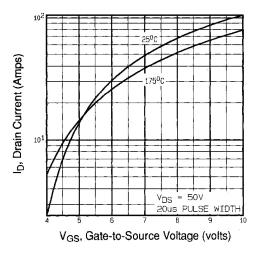


Fig. 3 - Typical Transfer Characteristics

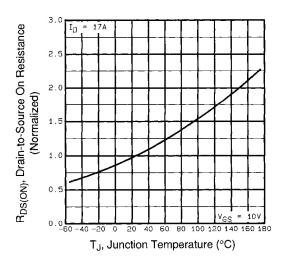


Fig. 4 - Normalized On-Resistance vs. Temperature

## IRFI510GPBF-VB

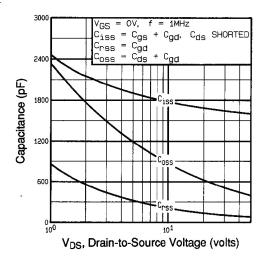
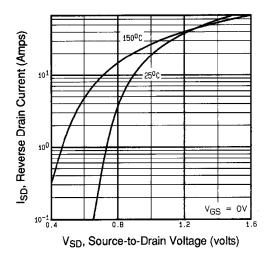


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



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Fig. 7 - Typical Source-Drain Diode Forward Voltage

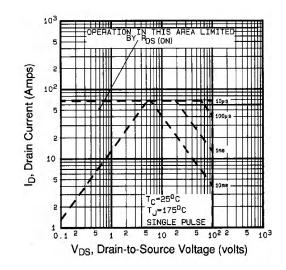


Fig. 8 - Maximum Safe Operating Area

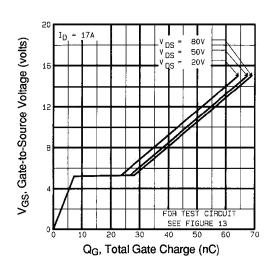


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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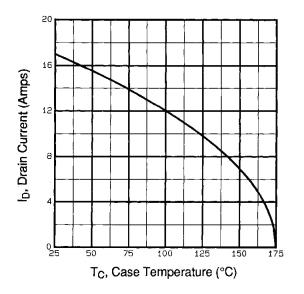


Fig. 9 - Maximum Drain Current vs. Case Temperature

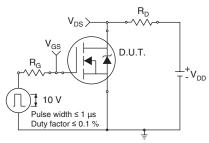


Fig. 10a - Switching Time Test Circuit

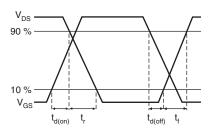


Fig. 10b - Switching Time Waveforms

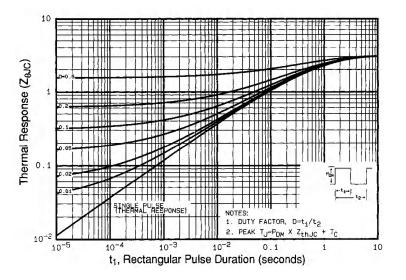


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

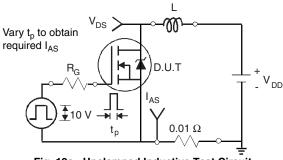


Fig. 12a - Unclamped Inductive Test Circuit

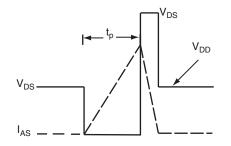


Fig. 12b - Unclamped Inductive Waveforms



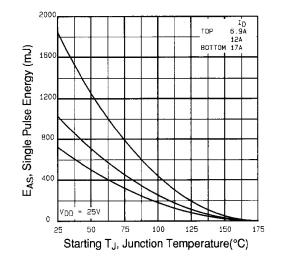


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

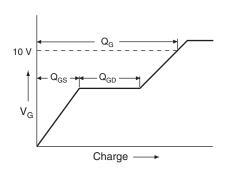
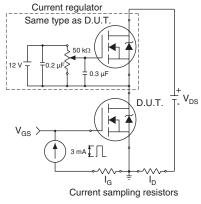
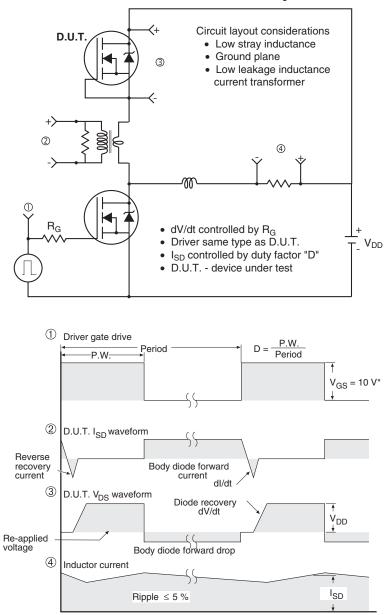


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS} = 5 V$  for logic level devices

Fig.14 - For N-Channel



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